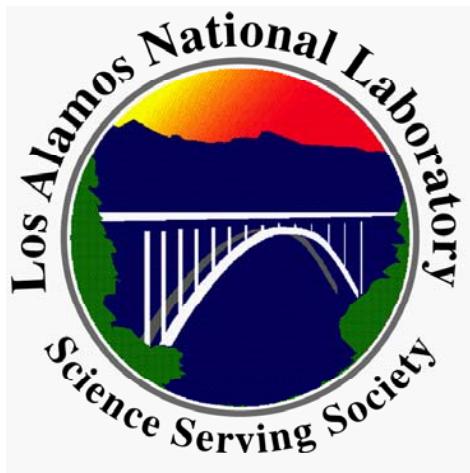


UNCERTAINTY QUANTIFICATION WORKING GROUP



A Definition of Simulation Uncertainty & A View of Total Uncertainty



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PART 1—A DEF'N OF SIMULATION UNCERTAINTY

Overview

- Why do we care?
- What is it?
- How does it apply to our models?
- What technologies are available?
- What technologies are being developed?
- What is the path forward?

WHY DO WE CARE ABOUT UNCERTAINTY?

- Science-based stockpile stewardship requires data and models
 - Test measurements
 - High-fidelity physics-based models (FEM, etc.)
 - Low-fidelity physics-based models (SDOF, etc.)
 - Surrogate models
- Decisions will be based on our model predictions
 - Safety
 - Security
 - Economic
 - Military
- Accuracy and robustness is crucial to acceptance
- Accuracy/robustness \Rightarrow quantified uncertainties

WHAT IS UNCERTAINTY?

- Aleatoric uncertainty (also called Variability)

- Inherent variation
- Irreducible

- Epistemic uncertainty (also called simply Uncertainty)

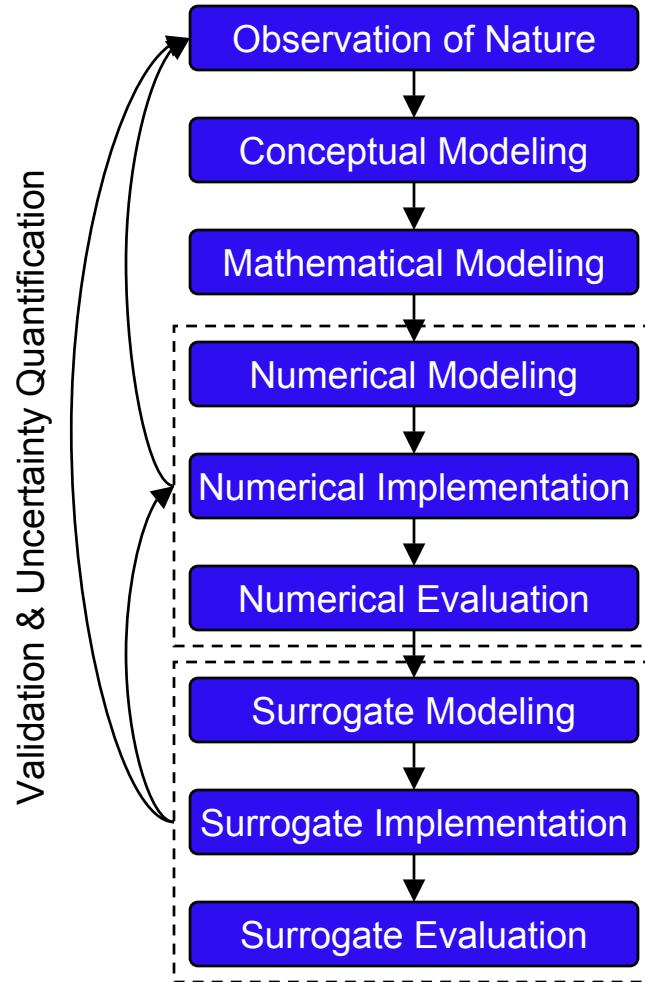
- Potential deficiency
- Lack of knowledge
- Reducible?

- Prejudicial uncertainty (also called Error)

- Recognizable deficiency
- Bias
- Reducible

HOW DOES IT APPLY TO OUR MODELS?

■ Phases of the modeling process

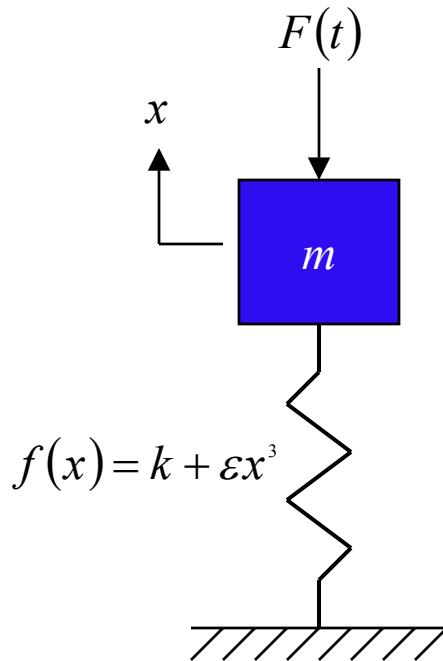


■ Sources of uncertainty

- Measurements
 - Noise
 - Resolution,
 - Quantization
 - Processing
- Mathematical models
 - Equations
 - Geometry
 - BCs/ICs
 - Inputs
 - Deterministic chaos
- Numerical models
 - Weak formulations
 - Discretizations
 - Approximate solution algorithms
 - Truncation and roundoff
- Surrogate models
 - Approximation error
 - Interpolation error
 - Extrapolation error
- Model parameters

A SIMPLE EXAMPLE

“Truth” Model



$$m\ddot{x} + kx + \varepsilon x^3 = F(t)$$
$$x(0) = x_0, \dot{x}(0) = \dot{x}_0$$

■ Measurement uncertainty

- Forcing function & ICs
- Response

■ Math model uncertainty

$$m\ddot{x} + kx = \hat{F}(t)$$

$$x(0) = \hat{x}_0, \dot{x}(0) = \dot{\hat{x}}_0$$

- Equation form
- Forcing function & Ics
- Sensitive dependence on ICs

■ Numerical solution uncertainty

- Integration algorithm
- Time step (discretization)

■ Parameters

$$\hat{m}, \hat{k}$$

WHAT TECHNOLOGIES ARE AVAILABLE?

■ Data

- Calibration w.r.t. conventional standards
- Noise characterization
- “Similar” or “inverse” signal processing

■ Mathematical models (Not much!)

■ Numerical models

- Bounds for discretization errors
- Bounds for approximate solution techniques
- Bounds for truncation/roundoff errors

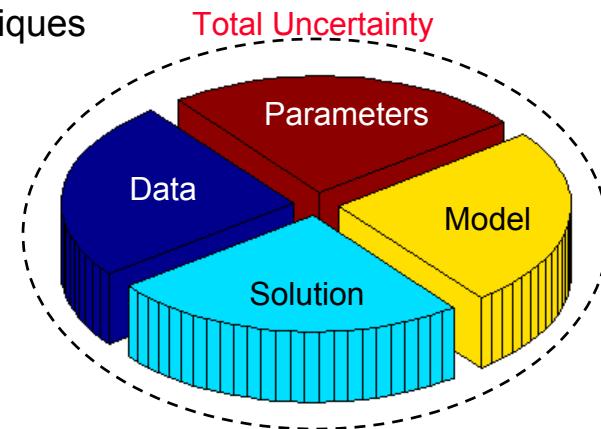
■ Surrogate models

- DOE
- Residual analysis
- ANOVA

■ Parameters

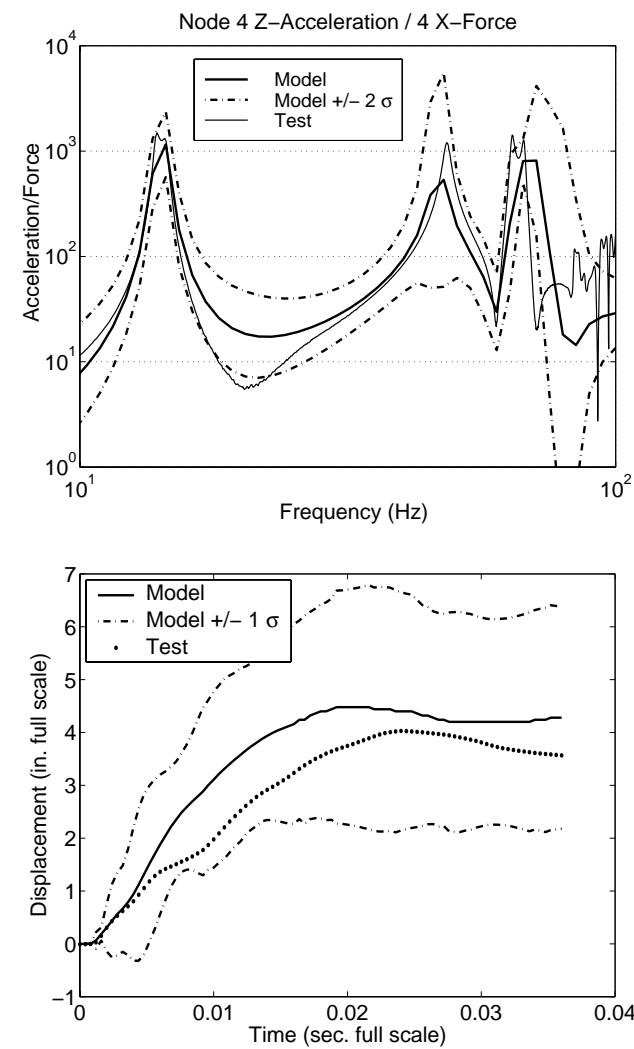
- Sensitivity analysis
- Monte Carlo
- Reliability methods (FORM, SORM, AMV, AMV+, FPI)
- Fuzzy set & interval propagation methods
- Stochastic FEM

■ Total uncertainty



GENERIC VIEW OF TOTAL UNCERTAINTY

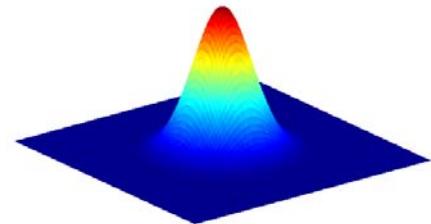
- Generic class of model-test pairs
- Normalized comparisons
- Uncertainty propagation



WHAT TECHNOLOGIES ARE BEING DEVELOPED?

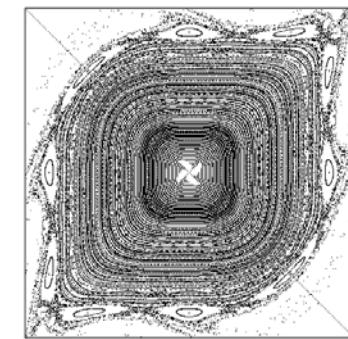
■ Measure theoretic methods

- Probability theories—frequentist, Bayesian, Koopman-Carnap
- Dempster-Schafer theory
- Possibility theory



■ Set theoretic methods

- Fuzzy set theories—classical, grey, intuitionistic, rough
- Interval arithmetic
- Convex sets & convex modeling



■ Dynamical systems methods

- Strange attractor theory
- Liapunov exponents
- Complexity theory

PROBABILITY THEORY V. DST

■ Probability theory—

Based on classical measure theory (additivity)

$$\Pr : 2^X \rightarrow [0,1]$$

$$\Pr(\emptyset) = 0$$

$$\Pr(X) = 1$$

$$\begin{aligned}\Pr\left(\bigcup_i A_i\right) &= \sum_i \Pr(A_i) - \sum_{j < k} \Pr(A_j \cap A_k) \\ &\quad + \dots + (-1)^{n+1} \Pr\left(\bigcap_i A_i\right)\end{aligned}$$

$$\begin{aligned}\Pr\left(\bigcap_i A_i\right) &= \sum_i \Pr(A_i) - \sum_{j < k} \Pr(A_j \cup A_k) \\ &\quad + \dots + (-1)^{n+1} \Pr\left(\bigcup_i A_i\right)\end{aligned}$$

■ Dempster-Schafer theory—

Based on fuzzy measure theory (monotonicity & semicontinuity)

$$\text{Bel} : 2^X \rightarrow [0,1] \quad \text{Pl} : 2^X \rightarrow [0,1]$$

$$\text{Bel}(\emptyset) = 0 \quad \text{Pl}(\emptyset) = 0$$

$$\text{Bel}(X) = 1 \quad \text{Pl}(X) = 1$$

$$\begin{aligned}\text{Bel}\left(\bigcup_i A_i\right) &\geq \sum_i \text{Bel}(A_i) - \sum_{j < k} \text{Bel}(A_j \cap A_k) \\ &\quad + \dots + (-1)^{n+1} \text{Bel}\left(\bigcap_i A_i\right)\end{aligned}$$

$$\begin{aligned}\text{Pl}\left(\bigcap_i A_i\right) &\leq \sum_i \text{Pl}(A_i) - \sum_{j < k} \text{Pl}(A_j \cup A_k) \\ &\quad + \dots + (-1)^{n+1} \text{Pl}\left(\bigcup_i A_i\right)\end{aligned}$$

PROBABILITY THEORY V. POSSIBILITY THEORY

■ Probability theory—

Based on classical measure theory (additivity)

$$\Pr : 2^X \rightarrow [0,1]$$

$$\Pr(\emptyset) = 0$$

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$$\begin{aligned}\Pr\left(\bigcap_i A_i\right) &= \sum_i \Pr(A_i) - \sum_{j < k} \Pr(A_j \cup A_k) \\ &\quad + \dots + (-1)^{n+1} \Pr\left(\bigcup_i A_i\right)\end{aligned}$$

■ Possibility theory—

Based on fuzzy measure theory (semicontinuity)

$$\text{Pos} : 2^X \rightarrow [0,1] \quad \text{Nec} : 2^X \rightarrow [0,1]$$

$$\text{Pos}(\emptyset) = 0 \quad \text{Nec}(\emptyset) = 0$$

$$\text{Pos}(X) = 1 \quad \text{Nec}(X) = 1$$

$$\text{Pos}\left(\bigcup_i A_i\right) = \sup_i \text{Pos}(A_i)$$

$$\text{Nec}\left(\bigcap_i A_i\right) = \inf_i \text{Nec}(A_i)$$

POTENTIAL UNCERTAINTY METRICS

■ Hartley measure for nonspecificity

$$H(A) = \log_2 |A|, |A| \text{ is cardinality of } A$$

■ Generalized Hartley measure for nonspecificity in DST

$$N(m) = \sum_{A \in 2^X} m(A) \log_2 |A|, m : 2^X \rightarrow [0,1], m(\emptyset) = 0, \sum_{A \in 2^X} m(A) = 1$$

■ U-uncertainty measure for nonspecificity in possibility theory

$$U(r) = \sum_{i=2}^n (r_i - r_{i+1}) \log_2 i, r(x) = \text{Pos}(\{x\}), r_i \geq r_{i+1} \forall i$$

■ Shannon entropy for total uncertainty in probability theory

$$S(p) = - \sum_{x \in X} p(x) \log_2 p(x)$$

■ Generalized Shannon entropy for total uncertainty in DST

$$AU(\text{Bel}) = \max_{p_x} \left(- \sum_{x \in X} p_x \log_2 p_x \right), \text{Bel}(A) \leq \sum_{x \in A} p_x \quad \forall A \in 2^X$$

■ Hamming distance for fuzzy sets

$$f(A) = \sum_{x \in X} [1 - |2A(x) - 1|], A(x) \text{ is membership function}$$

WHAT IS THE PATH FORWARD?

- Some type of uncertainty quantification is required
- Salient points
 - Measure predictive capability \Rightarrow Compare data & predictions
 - Experiments should be designed to facilitate comparisons
 - “Adequate” quantification of predictive capability \Rightarrow lots of data
 - Interpolation/extrapolation beyond observations \Rightarrow inference
- No comprehensive framework/toolbox exists
 - Application dependent
 - Different types of uncertainty require different tools
- Hypothetical approach
 - Characterize measurement uncertainty
 - Characterize/propagate parametric uncertainty
 - Bound/propagate solution uncertainty
 - Estimate (generically) total uncertainty
 - “Subtract” to estimate model uncertainty

PART 2—A VIEW OF TOTAL UNCERTAINTY

Overview

- What is total uncertainty?
- Prototypical application: linear structural dynamics
 - Methodology
 - Example: Space truss structure
- Generalization to arbitrary applications
 - Methodology
 - Example: Nose cone crushing
 - Example: Blast response of R/C wall
- Conclusions

WHAT IS TOTAL UNCERTAINTY?

- *Total uncertainty* is simply a measure of the difference between experimental data and model predictions
- Practical considerations
 - There rarely exists enough samples for a given simulation scenario
 - Simple differencing leads to “small differences of large numbers”
- A candidate approach
 - Consider “generic classes” of test-analysis comparisons
 - Normalize information so that differences are “perturbations”

PROTOTYPICAL APPLICATION: LINEAR DYNAMICS

■ Classical normal modes

$$({}^0K - {}^0\lambda {}^0M) \phi = 0 \quad \dots \text{analysis}$$

$$(K - \lambda M) \phi = 0 \quad \dots \text{test}$$

■ Normalization of test modes

$$\phi^T M \phi = I$$

■ Modal mass and stiffness matrices

$${}^0m = {}^0\phi^T M {}^0\phi = I$$

$${}^0k = {}^0\phi^T K {}^0\phi = {}^0\lambda$$

■ Cross-orthogonality of analysis and test modes

$$\phi = {}^0\phi \psi \dots \text{assumed}$$

$${}^0\phi^T M \phi = {}^0\phi^T M {}^0\phi \psi = \psi$$

■ Assumed “true” modal mass and stiffness matrices

$$m = {}^0m + \Delta m = I + \Delta m$$

$$k = {}^0k + \Delta k = {}^0\lambda + \Delta k$$

■ Differences between analysis and test modes

$$\Delta \lambda = \lambda - {}^0\lambda$$

$$\Delta \phi = \phi - {}^0\phi = {}^0\phi(\psi - I) = {}^0\phi \Delta \psi$$

PROTOTYPICAL APPLICATION (CONT'D)

- Normalized modal metrics for total uncertainty quantification

$$\Delta m = -(\Delta \psi + \Delta \psi^T)$$

$$\Delta \tilde{k} = {}^0\lambda^{-1/2} (\Delta \lambda - {}^0\lambda \Delta \psi - \Delta \psi^T {}^0\lambda) {}^0\lambda^{-1/2}$$

$$\Delta \zeta = \zeta - {}^0\zeta$$

- Vectorization of normalized differences

$$\Delta \tilde{r} = \begin{Bmatrix} \text{vec}(\Delta m) \\ \text{vec}(\Delta \tilde{k}) \\ \text{vec}(\Delta \zeta) \end{Bmatrix}$$

- Structure-specific covariance matrix of uncertainty (biased)

$$\mu_{\Delta \tilde{r}} = E[\Delta \tilde{r}]$$

$$S_{\tilde{r}\tilde{r}} = E[(\Delta \tilde{r} - \mu_{\Delta \tilde{r}})(\Delta \tilde{r} - \mu_{\Delta \tilde{r}})^T]$$

- Generic covariance matrix of total uncertainty (unbiased)

$$\mu_{\Delta \tilde{r}} = 0 \dots \text{assumed}$$

$$S_{\tilde{r}\tilde{r}} = E[\Delta \tilde{r} \Delta \tilde{r}^T]$$

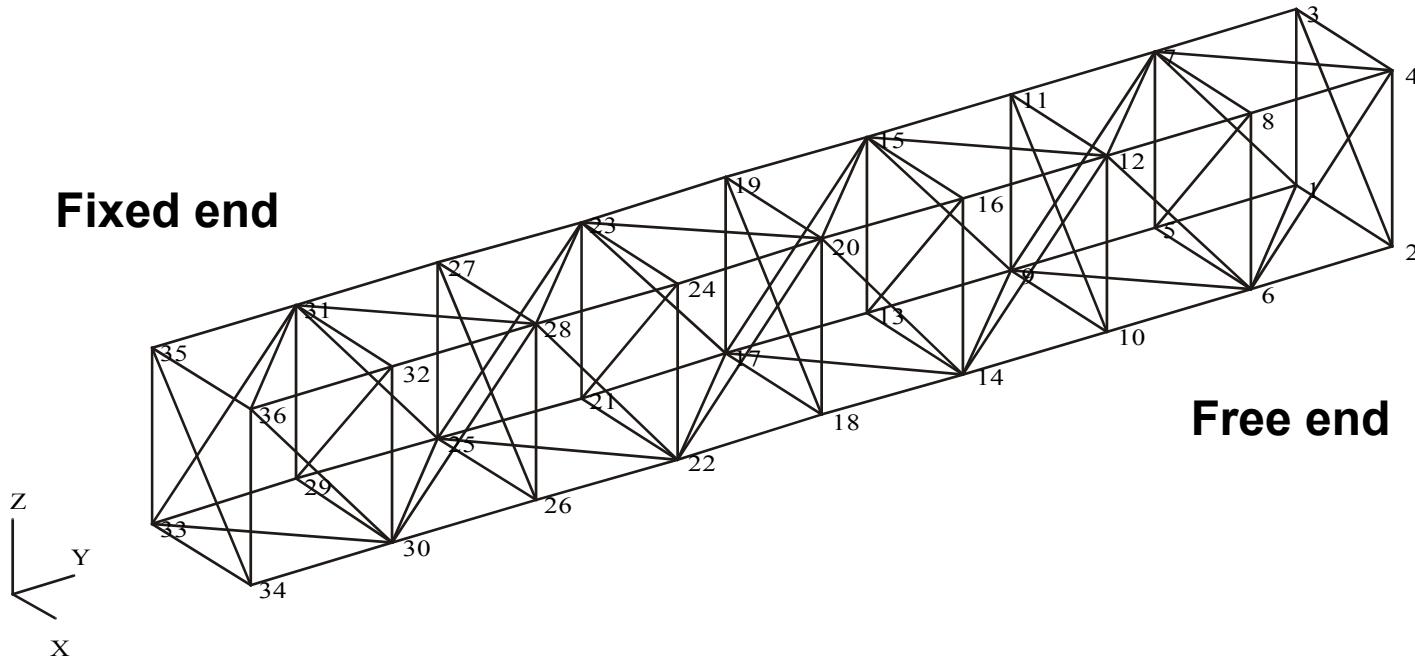
- Propagate thru model

- Linear covariance propagation
- Interval propagation
- Monte Carlo simulation

EXAMPLE: SPACE TRUSS STRUCTURE

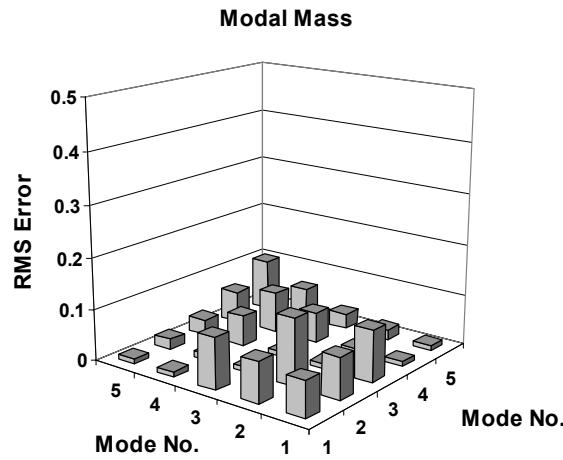
NASA/LaRC 8-bay truss structure

- Force input at Nodes 4 and 7
- Acceleration response measured at Nodes 1 through 32

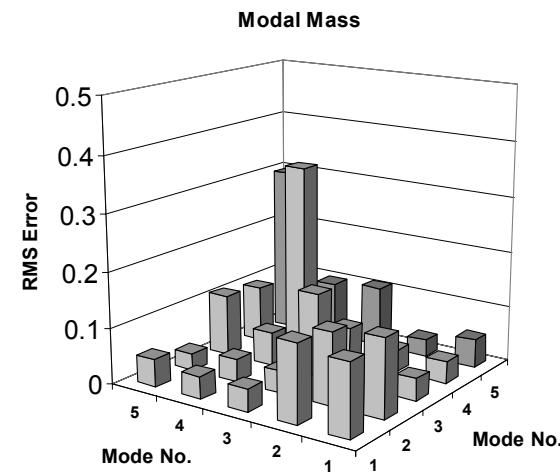


STRUCTURE-SPECIFIC VS. GENERIC VARIATION

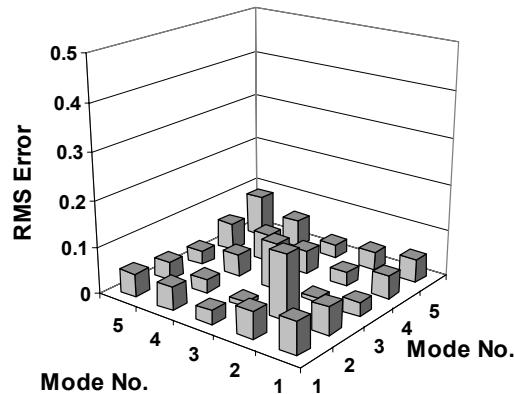
Structure-specific variability



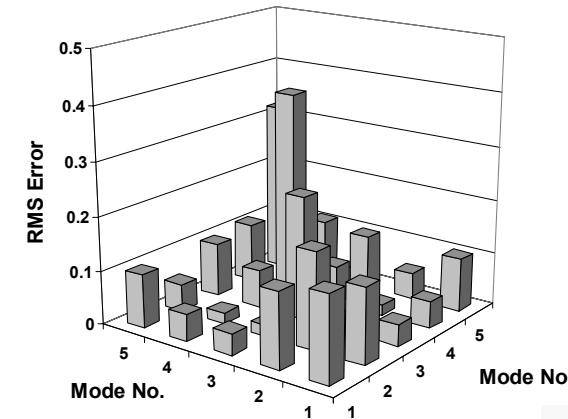
Generic class variability



Normalized Modal Siffness



Normalized Modal Stiffness

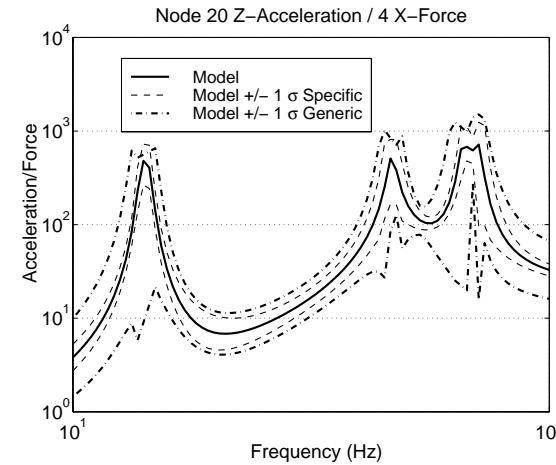
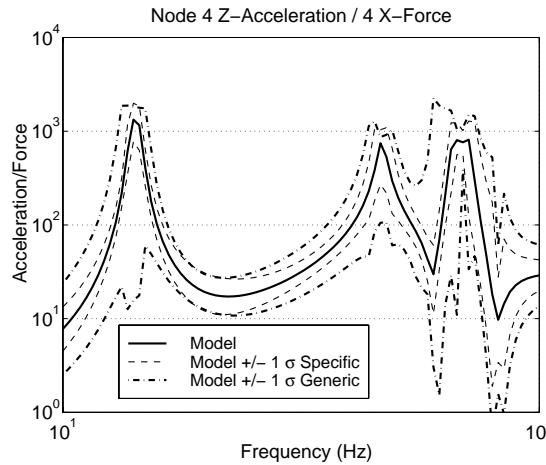
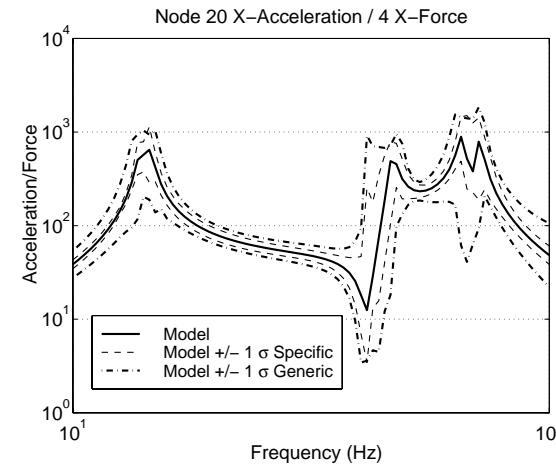
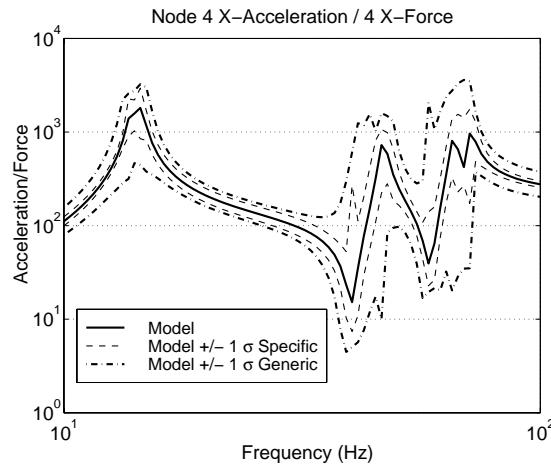


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PREDICTIVE ACCURACY FOR SPACE TRUSS



DX

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GENERALIZATION TO ARBITRARY APPLICATIONS

■ Response matrix

$$X = \begin{bmatrix} x(t_1; \theta_1) & x(t_1; \theta_2) & \cdots & x(t_1; \theta_n) \\ x(t_2; \theta_1) & x(t_2; \theta_2) & \cdots & x(t_2; \theta_n) \\ \vdots & \vdots & \ddots & \vdots \\ x(t_m; \theta_1) & x(t_m; \theta_2) & \cdots & x(t_m; \theta_n) \end{bmatrix}$$

■ Singular value decomposition

$$X = U\Sigma V^T$$

$$= \underbrace{\begin{bmatrix} \overbrace{\eta^T}^{m \times p} & \overbrace{\eta_\perp^T}^{m \times (m-p)} \\ \hdashline \dots & \dots \end{bmatrix}}_{m \times m} \underbrace{\begin{bmatrix} \overbrace{D}^{p \times p} & & \overbrace{0}^{p \times (n-p)} \\ \hdashline & \dots & \dots \\ \overbrace{0}^{(m-p) \times p} & & \overbrace{0}^{(m-p) \times (n-p)} \end{bmatrix}}_{m \times n} \underbrace{\begin{bmatrix} \overbrace{\phi^T}^{p \times n} \\ \hdashline \dots \\ \overbrace{\phi_\perp^T}^{(n-p) \times n} \end{bmatrix}}_{n \times n}$$

$$= \eta^T D \phi^T, \quad \eta \eta^T = \phi^T \phi = I_p$$

[Note: Papers use " X " = $X^T = \phi D \eta$]

GENERALIZATION (CONT'D)

■ Differences between analysis and test

$$\Delta\phi = \phi - {}^0\phi$$

$$\Delta D = D - {}^0D$$

$$\Delta\eta = \eta - {}^0\eta$$

■ Cross-orthogonality matrices

$$\psi = {}^0\phi^T \phi$$

$$\nu = {}^0\eta \eta^T$$

■ Normalized differences

$$\Delta\psi = \psi - I_p$$

$$\Delta\nu = \nu - I_p$$

$$\Delta\tilde{D} = \frac{1}{\text{Trace}({}^0D)}(D - {}^0D)$$

■ Vectorization of differences

$$\Delta\tilde{r} = \begin{Bmatrix} \text{vec}(\Delta m) \\ \text{vec}(\Delta\tilde{k}) \\ \text{vec}(\Delta\zeta) \end{Bmatrix}$$

■ Structure-specific covariance matrix of uncertainty (biased)

$$\mu_{\Delta\tilde{r}} = E[\Delta\tilde{r}]$$

$$S_{\tilde{R}\tilde{R}} = E[(\Delta\tilde{r} - \mu_{\Delta\tilde{r}})(\Delta\tilde{r} - \mu_{\Delta\tilde{r}})^T]$$

■ Generic covariance matrix of total uncertainty (unbiased)

$$\mu_{\Delta\tilde{r}} = 0 \dots \text{assumed}$$

$$S_{\tilde{R}\tilde{R}} = E[\Delta\tilde{r}\Delta\tilde{r}^T]$$

GENERALIZATION (CONT'D)

- Consider data as function of normalized parameters

$$u(\tilde{r}) = \text{vec}[X(\tilde{r})]$$

- First order Taylor series approximation of data

$$\Delta u \approx T_{u\tilde{r}} \Delta \tilde{r}, \quad \Delta u = u(\tilde{r}) - u({}^0\tilde{r}), \quad (T_{u\tilde{r}})_{ij} = \frac{\partial u_i}{\partial \tilde{r}_j} \Big|_{\tilde{r}={}^0\tilde{r}}$$

- “Propagate” uncertainty

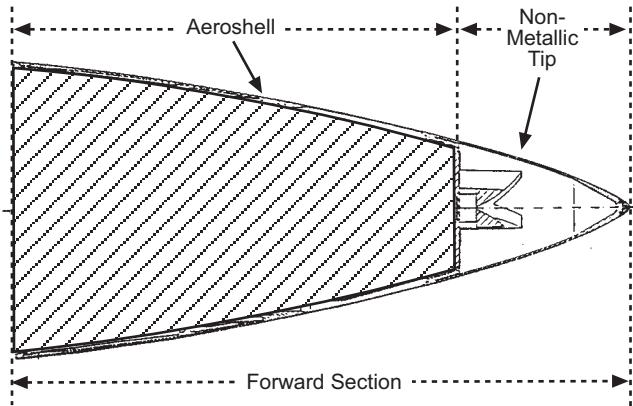
$$\begin{aligned} S_{UU} &= E(\Delta u \Delta u^T) \\ &\approx E(T_{u\tilde{r}} \Delta \tilde{r} \Delta \tilde{r}^T T_{u\tilde{r}}^T) \\ &\approx T_{u\tilde{r}} S_{\tilde{R}\tilde{R}} T_{u\tilde{r}}^T \end{aligned}$$

- Generate uncertainty bands

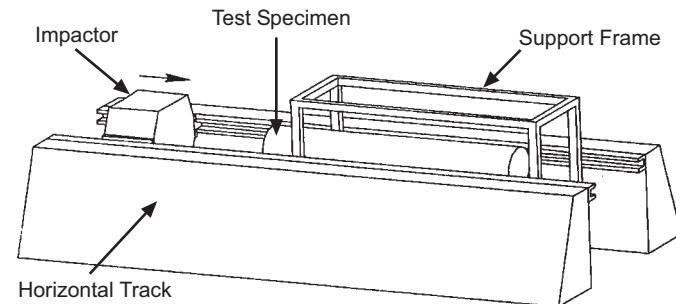
$$\sigma_U = \text{diag} \begin{bmatrix} \sqrt{(S_{UU})_{11}} & & 0 \\ & \ddots & \\ 0 & & \sqrt{(S_{UU})_{n_u n_u}} \end{bmatrix}$$

EXAMPLE: NOSE CONE CRUSHING

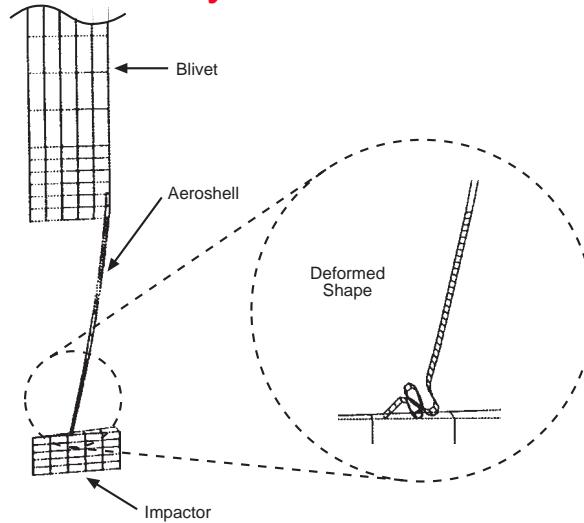
Nosecone aeroshell



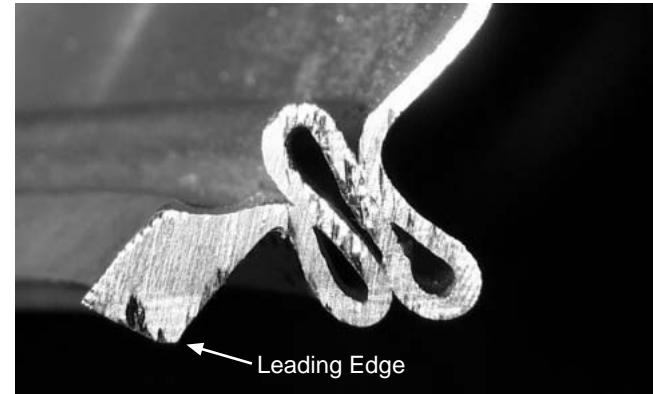
Test setup



Simplified, axisymmetric DYNA3D model



Actual buckling pattern



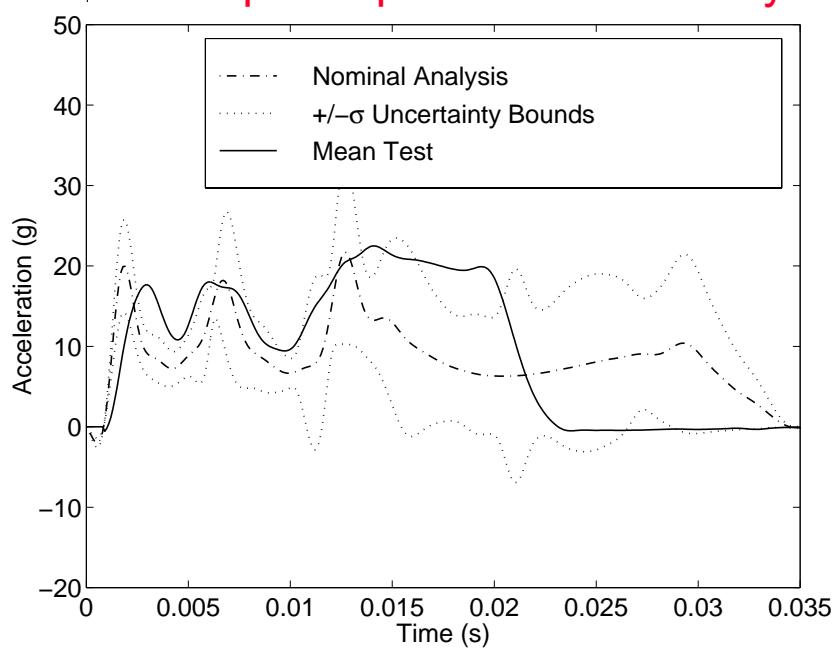
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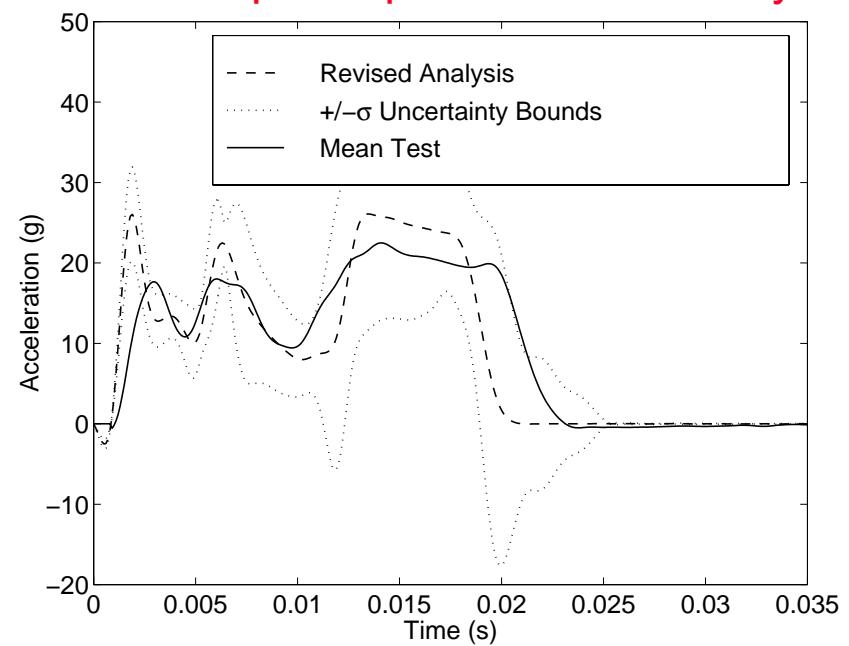


PREDICTIVE ACCURACY FOR NOSE CONE

Pre-update predictive accuracy



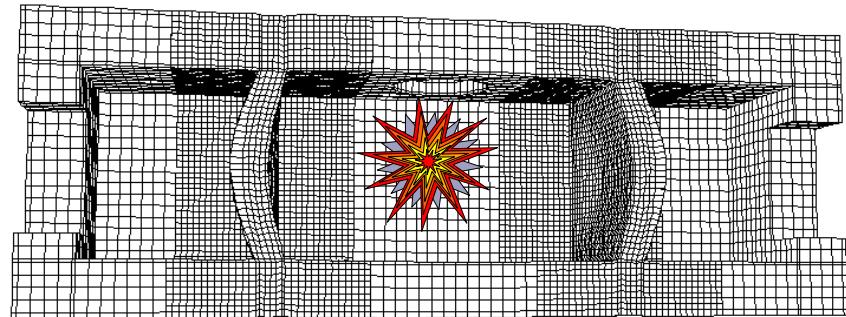
Post-update predictive accuracy



EXAMPLE: BLAST RESPONSE OF R/C WALL

■ Scenario

- 3-room buried bunker
- Explosion in center room

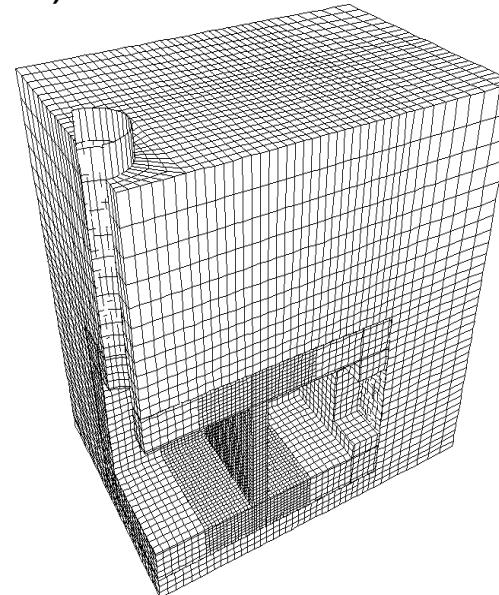


■ Measurements

- Displacements (12 sensors, 4 locations)
- Pressures (10 sensors, 9 distinct locations)

■ Structure model

- DYNA3D (customized LLNL version)
- ~80,000 continuum elements
- ~20,000 beam elements



■ Load model

- CFD code (SHARC?)
- Uncoupled from structure
- Validated w.r.t. pressure measurements

DX

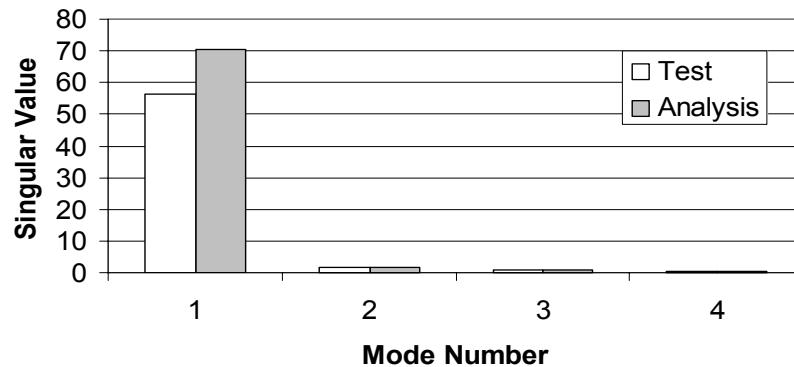
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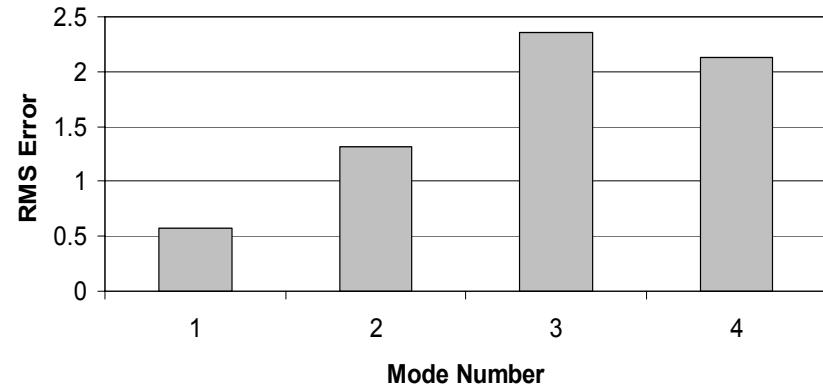


GENERIC CLASS VARIATION

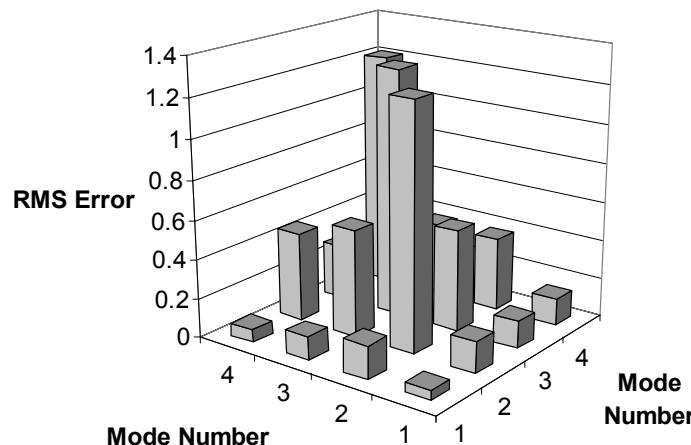
Typical Singular Values



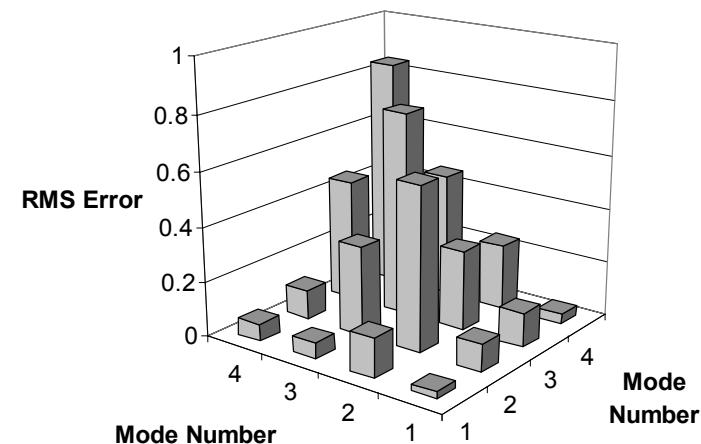
Normalized Singular Values



Left Eigenvector Cross-Orthogonality

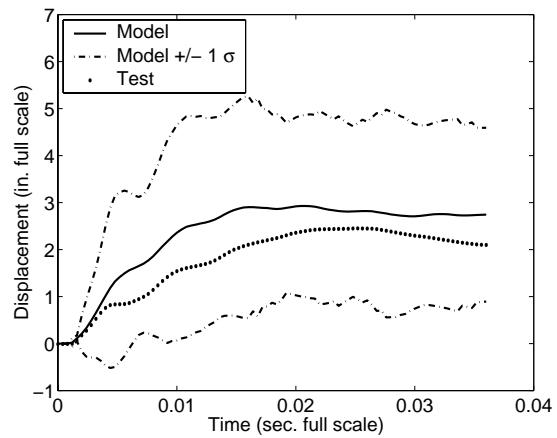


Right Eigenvector Cross-Orthogonality

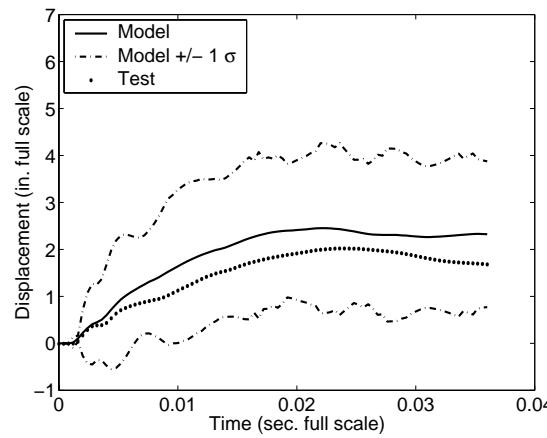


PRE-UPDATE PREDICTIVE ACCURACY FOR R/C WALL

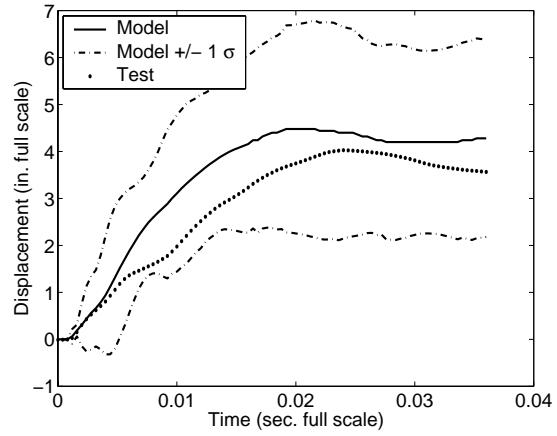
Left Horizontal Quarter Point



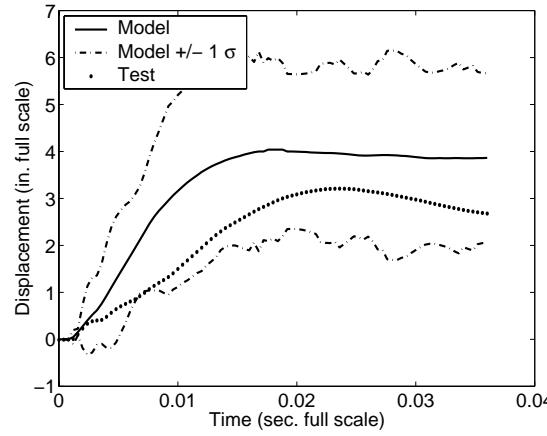
Upper Vertical Quarter Point



Center Point



Lower Vertical Quarter Point



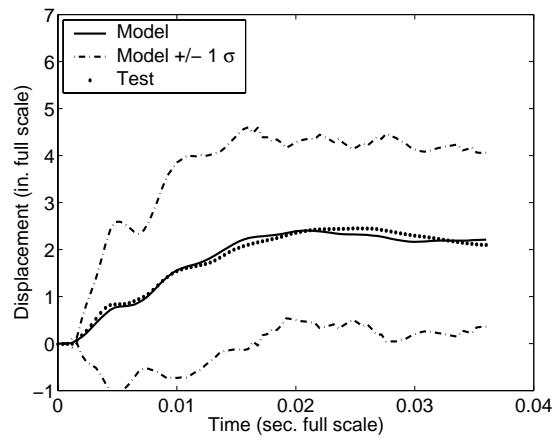
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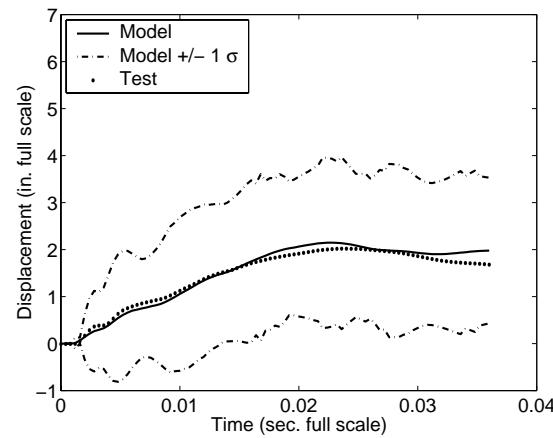


POST-UPDATE PREDICTIVE ACCURACY FOR R/C WALL

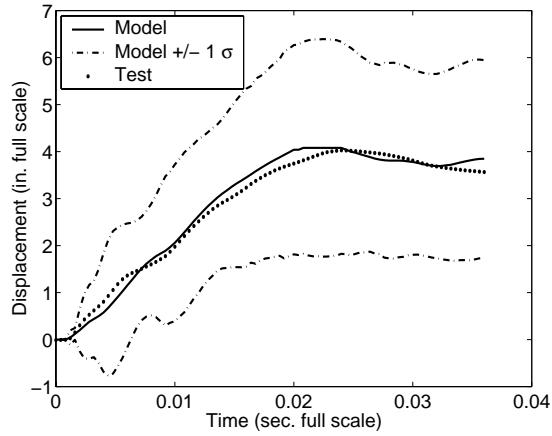
Left Horizontal Quarter Point



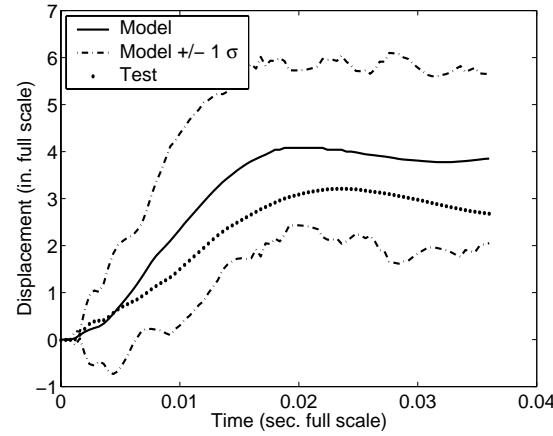
Upper Vertical Quarter Point



Center Point



Lower Vertical Quarter Point



Dynamic Experimentation Division

UNCERTAINTY QUANTIFICATION WORKING GROUP-6/28/01-29



CONCLUSIONS

- Total uncertainty quantification requires
 - A generic class of test-analysis pairs
 - A means of normalizing the differences
 - A method for propagating uncertainty thru the model
- Total uncertainty is more realistic than parametric uncertainty
- Some unresolved questions
 - How are generic classes defined/interpreted?
 - What are the statistical issues involved?
 - Can this approach be made rigorous?
 - Can total uncertainty be used in conjunction with other types of uncertainty quantification to deal with the issue of model uncertainty?